

**Notice of References Cited**

Application/Control No.

10/520,648

Applicant(s)/Patent Under  
Reexamination  
ENGEL ET AL.

Examiner

Sunray R. Chang

Art Unit

2121

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,314,379 B1	11-2001	Hu et al.	702/81
*	B	US-6,030,731 A	02-2000	Yang, Baorui	430/5
*	C	US-6,548,417 B2	04-2003	Dao et al.	438/710
*	D	US-2001/0027917	10-2001	Ferranti et al.	204/192.11
*	E	US-5,424,548	06-1995	Puisto, Denise M.	250/491.1
*	F	US-5,541,411	07-1996	Lindquist et al.	250/309
*	G	US-6,091,845	07-2000	Pierrat et al.	382/144
*	H	US-2002/0019729	02-2002	CHANG et al.	703/6
*	I	US-6,069,366	05-2000	Goruganthu et al.	250/559.27
*	J	US-4,737,641	04-1988	Lange et al.	250/585
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(e).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.